

RoHS Compliant Product
A suffix of "C" specifies halogen & lead-free

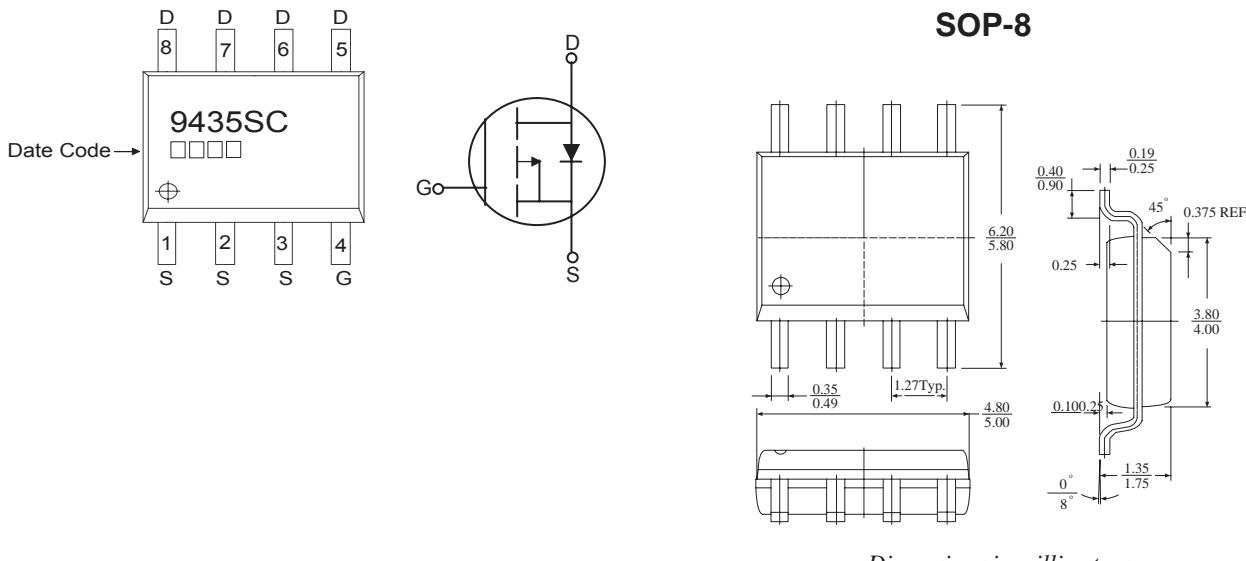
DESCRIPTION

The SSG9435 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The SOP-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

FEATURES

- Simple Drive Requirement
- Lower On-resistance
- Fast Switching Performance

PACKAGE DIMENSIONS



Dimensions in millimeters

ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | P-ch Ratings | Unit |
|--|-----------------------|--------------|------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 16 | V |
| Continuous Drain Current ³ , $VGS@ 10V$ | $I_D @ Ta=25^\circ C$ | -5.3 | A |
| Continuous Drain Current ³ , $VGS@ 10V$ | $I_D @ Ta=70^\circ C$ | -4.7 | A |
| Pulsed Drain Current ¹ , | I_{DM} | -20 | A |
| Total Power Dissipation | $P_D @ Ta=25^\circ C$ | 2.5 | W |
| Operating Junction and Storage Temperature Range | T_j, T_{stg} | -55 ~ +150 | °C |
| Linear Derating Factor | | 0.02 | W/°C |

THERMAL DATA

| Parameter | Symbol | Value | Unit |
|--|--------------------|-------|--------|
| Thermal Resistance Junction-ambient Max. | $R_{\theta j-amb}$ | 50 | °C / W |

P-CHANNEL ELECTRICAL CHARACTERISTICS (T_j = 25°C unless otherwise specified)

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test Conditions |
|--|-------------------------------------|------|--------|------|------|---|
| Drain-Source Breakdown Voltage | BVDSS | -30 | - | - | V | V _{GS} =0, I _D =-250uA |
| Breakdown Voltage Temp. Coefficient | △BV _{DSS} /△T _j | - | -0.037 | - | V/°C | Reference to 25°C, I _D =-1mA |
| Gate Threshold Voltage | V _{GS(th)} | -1.0 | - | -3.0 | V | V _{DS} =V _{GS} , I _D =-250uA |
| Forward Transconductance | g _{fs} | - | 10 | - | S | V _{DS} =-10V, I _D =-5.3A |
| Gate-Source Leakage Current | I _{GSS} | - | - | ±100 | nA | V _{GS} = ±16V |
| Drain-Source Leakage Current(T _j =25°C) | I _{DSS} | - | - | -1 | uA | V _{DS} =-30V, V _{GS} =0 |
| Drain-Source Leakage Current(T _j =70°C) | | - | - | -5 | uA | V _{DS} =-24V, V _{GS} =0 |
| Static Drain-Source On-Resistance | R _{DS(ON)} | - | - | 55 | mΩ | V _{GS} =-10V, I _D =-5.3A |
| | | - | - | 90 | | V _{GS} =-4.5 V, I _D =-4.2 A |
| Total Gate Charge ² | Q _g | - | 28 | - | nC | I _D =-5.3 A V _{DS} =-15 V V _{GS} =-10 V |
| Gate-Source Charge | Q _{gs} | - | 3 | - | | |
| Gate-Drain ("Miller") Charge | Q _{gd} | - | 7 | - | | |
| Turn-on Delay Time ² | T _{d(on)} | - | 9 | - | ns | V _{DS} =-15 V I _D =-1 A V _{GS} =-10 V R _G =6 Ω R _D =15 Ω |
| Rise Time | T _r | - | 15 | - | | |
| Turn-off Delay Time | T _{d(off)} | - | 75 | - | | |
| Fall Time | T _f | - | 40 | - | | |
| Input Capacitance | C _{iss} | - | 745 | - | pF | V _{GS} =0 V V _{DS} =-15 V f=1.0 MHz |
| Output Capacitance | C _{oss} | - | 440 | - | | |
| Reverse Transfer Capacitance | C _{rss} | - | 120 | - | | |

SOURCE-DRAIN DIODE

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test Conditions |
|---|-----------------|------|-------|------|------|---|
| Forward On Voltage ² | V _{SD} | - | -0.75 | -1.2 | V | I _S =-2.6A, V _{GS} =0 V, T _j =25°C |
| Continuous Source Current (Body Diode) | I _S | - | - | -2.6 | A | V _D = V _G = 0V, V _S = -1.2 V |
| Pulsed Source Current (Body Diode) ¹ | I _{SM} | - | - | -20 | A | |

Notes: 1. Pulse width limited by Max. junction temperature.
2. Pulse width ≤ 300us, duty cycle ≤ 2%.

CHARACTERISTIC CURVE

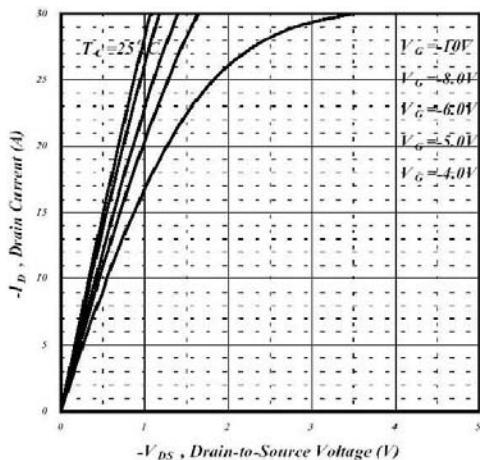


Fig 1. Typical Output Characteristics

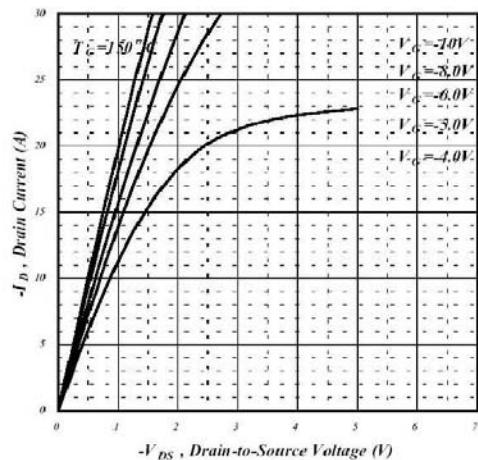


Fig 2. Typical Output Characteristics

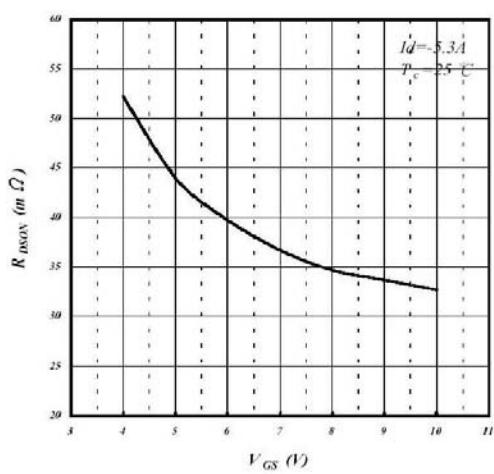


Fig 3. On-Resistance v.s. Gate Voltage

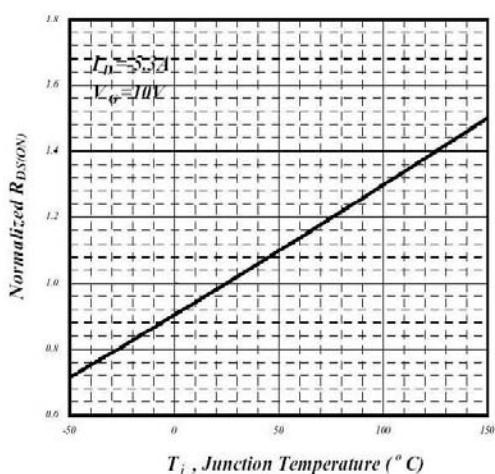


Fig 4. Normalized On-Resistance v.s. Junction Temperature

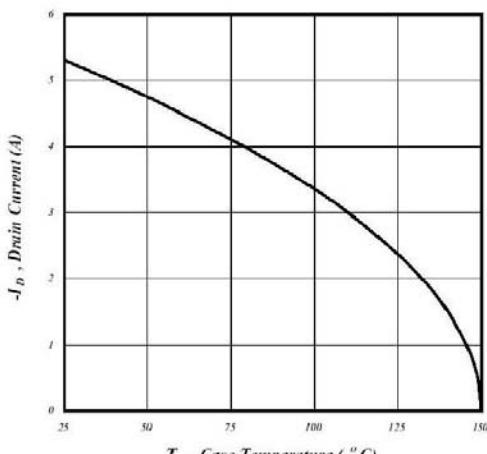


Fig 5. Maximum Drain Current v.s. Case Temperature

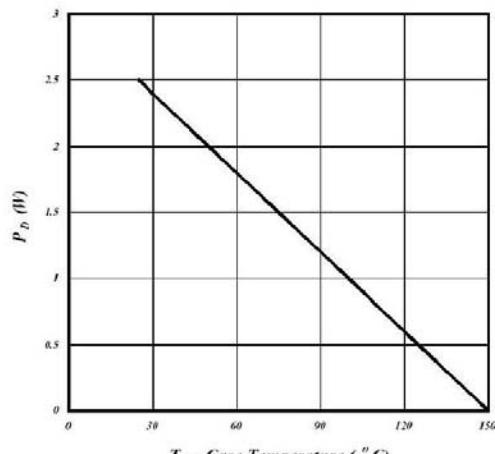


Fig 6. Type Power Dissipation

CHARACTERISTIC CURVE (cont'd)

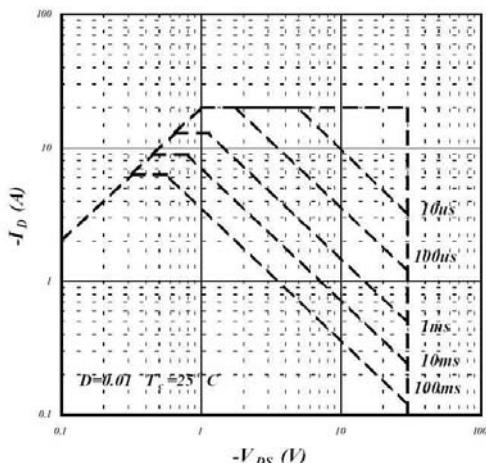


Fig 7. Maximum Safe Operating Area

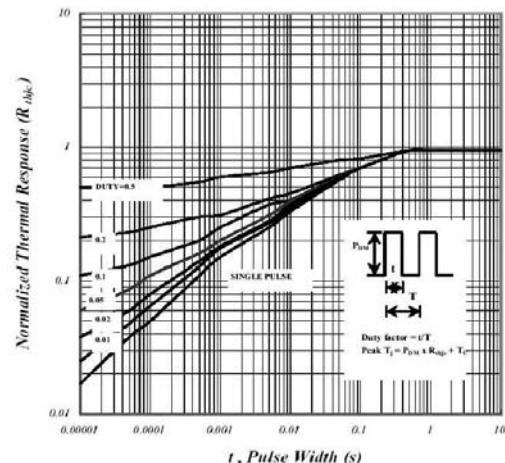


Fig 8. Effective Transient Thermal Impedance

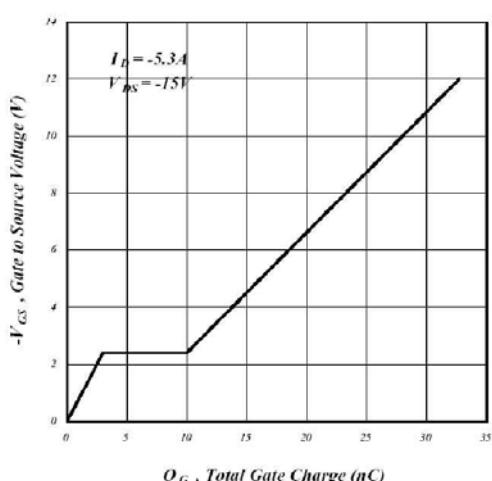


Fig 9. Gate Charge Characteristics

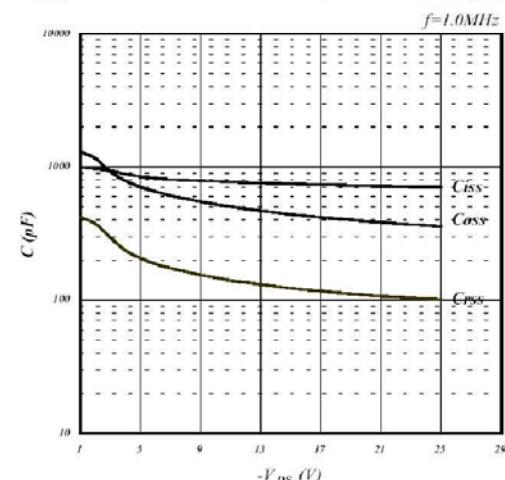


Fig 10. Typical Capacitance Characteristics

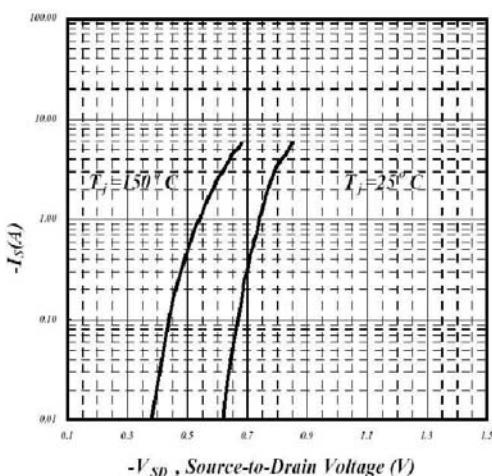


Fig 11. Forward Characteristics of Reverse Diode

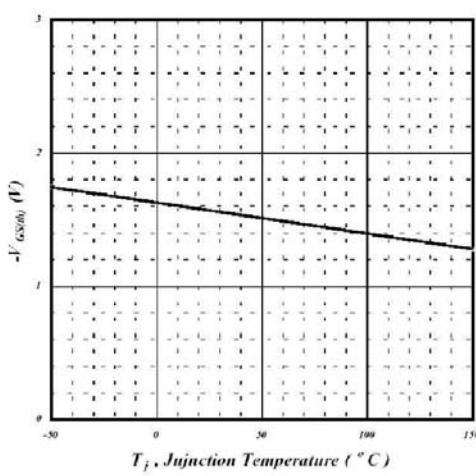


Fig 12. Gate Threshold Voltage v.s. Junction Temperature

CHARACTERISTIC CURVE (cont'd)

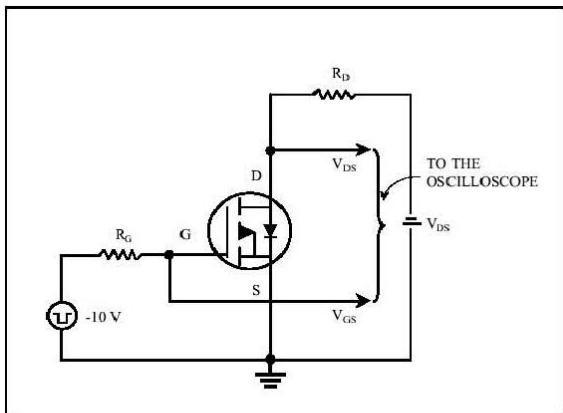


Fig 13. Switching Time Circuit

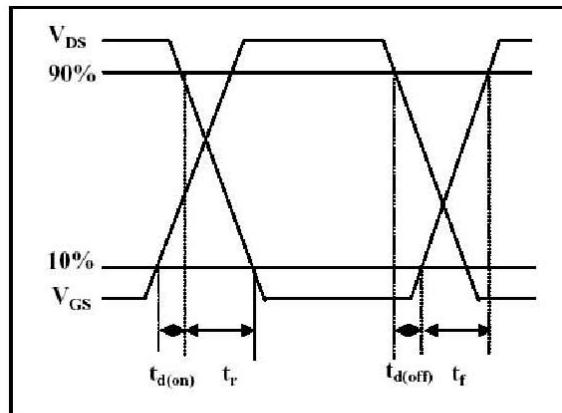


Fig 14. Switching Time Waveform

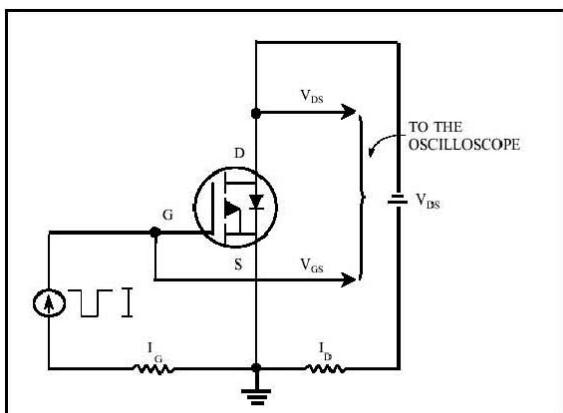


Fig 15. Gate Charge Circuit

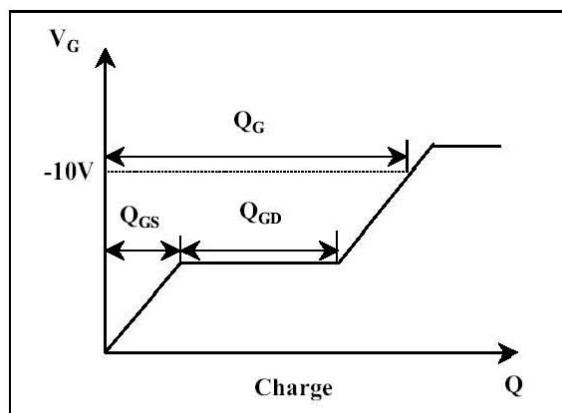


Fig 16. Gate Charge Waveform